

# GP2S27J0000F Series

SMT, Detecting Distance : 0.7mm  
Phototransistor Output,  
Compact Reflective  
Photointerrupter



## ■ Description

**GP2S27J0000F Series** is a compact-package, photo-transistor output, reflective photointerrupter, with emitter and detector facing the same direction in a molding that provides non-contact sensing. The compact package series is a result of unique technology, combining transfer and injection molding, that also blocks visible light to minimize false detection.

This photointerrupter can be ordered in different CTR ranks, and comes in a surface-mount, gullwing lead package, suitable for reflow soldering.

## ■ Features

1. Reflective with Phototransistor Output
2. Highlights :
  - Compact Size
  - Surface Mount Type (SMT), reflow soldering, with gullwing leads
  - Optional Tape and Reel (T&R) 1 000 pcs per reel
3. Key Parameters :
  - Optimal Sensing Distance : 0.7mm
  - Package : 4x3x1.7mm
  - Visible light cut resin to prevent
4. Lead free and RoHS directive compliant

## ■ Agency approvals/Compliance

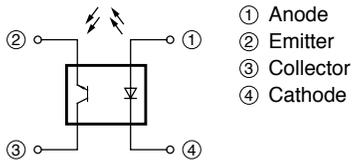
1. Compliant with RoHS directive

## ■ Applications

1. Detection of object presence or motion.
2. Example : printer, optical storage

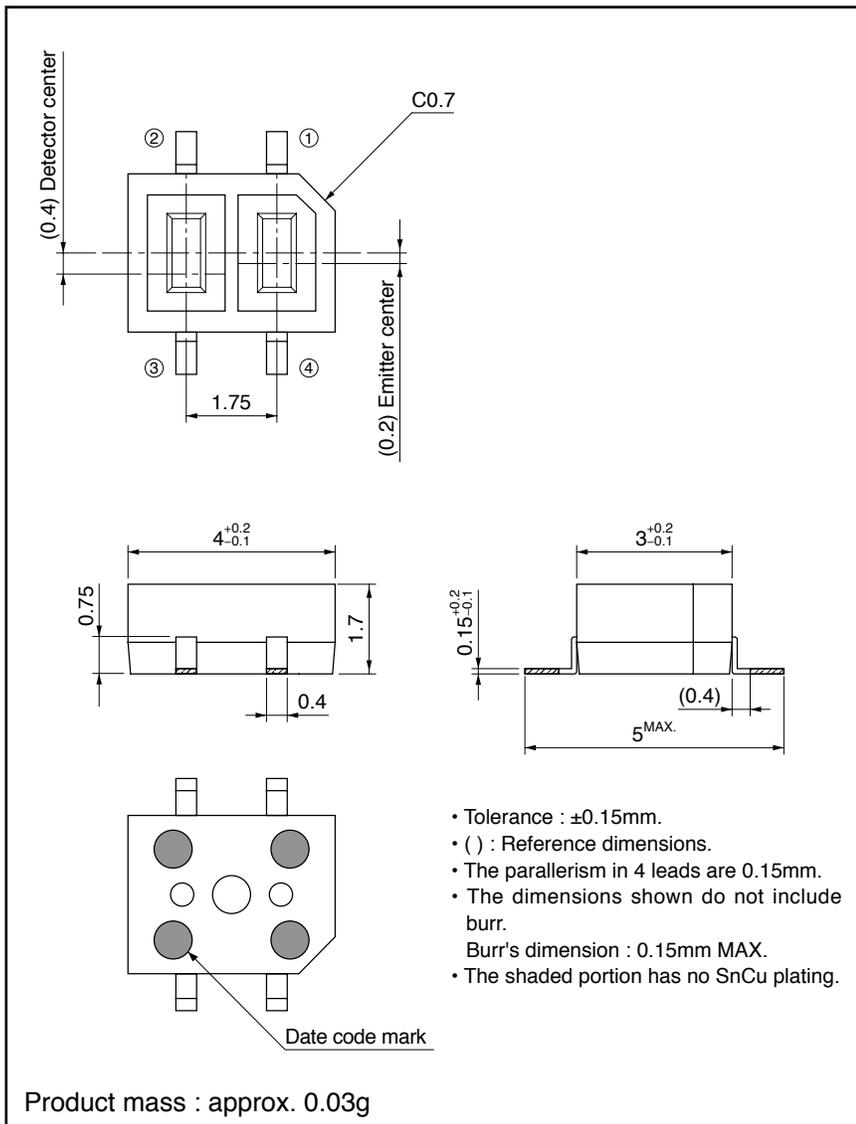


## Internal Connection Diagram



## Outline Dimensions

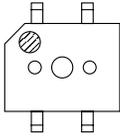
(Unit : mm)



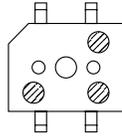
Plating material : SnCu (Cu : TYP. 2%)

### Date code (Symbol)

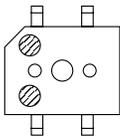
January



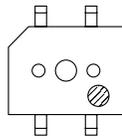
July



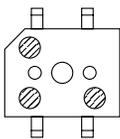
February



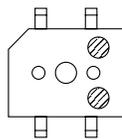
August



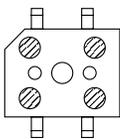
March



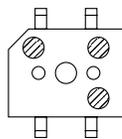
September



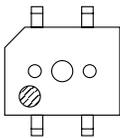
April



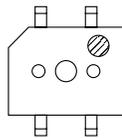
October



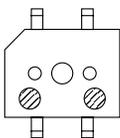
May



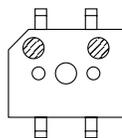
November



June



December



### Rank mark

There is no rank indicator.

### Country of origin

Japan

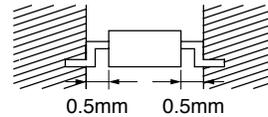
### ■ Absolute Maximum Ratings (T<sub>a</sub>=25°C)

Parameter		Symbol	Rating	Unit
Input	Forward current	I <sub>F</sub>	50	mA
	Reverse voltage	V <sub>R</sub>	6	V
	Power dissipation	P	75	mW
Output	Collector-emitter voltage	V <sub>CEO</sub>	35	V
	Emitter-collector voltage	V <sub>ECO</sub>	6	V
	Collector current	I <sub>C</sub>	20	mA
	Collector power dissipation	P <sub>C</sub>	75	mW
Total power dissipation		P <sub>tot</sub>	100	mW
Operating temperature		T <sub>opr</sub>	-25 to +85	°C
Storage temperature		T <sub>stg</sub>	-40 to +100	°C
*1 Soldering temperature		T <sub>sol</sub>	260	°C

\*1 For 5s or less

Soldering area:

The hatched area more than 0.5mm away from the lower edge of package as shown in the figure below.



### ■ Electro-optical Characteristics (T<sub>a</sub>=25°C)

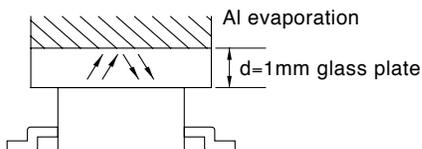
Parameter		Symbol	Condition	MIN.	TYP.	MAX.	Unit	
Input	Forward voltage	V <sub>F</sub>	I <sub>F</sub> =20mA	-	1.2	1.4	V	
	Reverse current	I <sub>R</sub>	V <sub>R</sub> =6V	-	-	10	μA	
Output	Collector dark current	I <sub>CEO</sub>	V <sub>CE</sub> =20V	-	1	100	nA	
Transfer characteristics	*2 Collector Current		I <sub>C</sub>	I <sub>F</sub> =4mA, V <sub>CE</sub> =2V	20	45	120	μA
	Response time	Rise time	t <sub>r</sub>	V <sub>CE</sub> =2V, I <sub>C</sub> =100μA, R <sub>L</sub> =1kΩ, d=1mm	-	20	100	μs
		Fall time	t <sub>f</sub>		-	20	100	
*3 Leak current		I <sub>LEAK</sub>	I <sub>F</sub> =4mA, V <sub>CE</sub> =2V	-	-	100	nA	

\*2 The condition and arrangement of the reflective object are shown below.  
The rank splitting of collector current (I<sub>C</sub>) shall be executed according to the table below.

Rank	Collector current, I <sub>C</sub> [μA] (I <sub>F</sub> =4mA, V <sub>CE</sub> =2V)	Package oleeve color
A	20 to 42	Yellow
B	34 to 71	Transparent
C	58 to 120	Green

\*3 Without reflective object.

### ● Test Condition and Arrangement for Collector Current



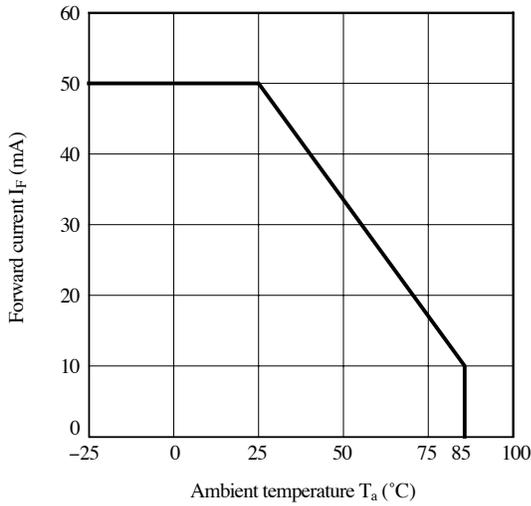
**■ Model Line-up**

Package	Sleeve	Taping	Rank	Collector current $I_C$ [ $\mu$ A] ( $I_F=4\text{mA}$ , $V_{CE}=2\text{V}$ , $T_a=25^\circ\text{C}$ )
	50 pcs/sleeve	1 000 pcs/reel		
Model No	<b>GP2S27J0000F</b>	<b>GP2S27TJ000F</b>	A, B or C	20 to 120
	<b>GP2S27BJ000F</b>	<b>GP2S27T2J00F</b>	B	34 to 71
	<b>GP2S27CJ000F</b>	<b>GP2S27T3J00F</b>	C	58 to 120
	<b>GP2S27ABJ00F</b>	<b>GP2S27T5J00F</b>	A or B	20 to 71
	<b>GP2S27BCJ00F</b>	<b>GP2S27T6J00F</b>	B or C	34 to 120

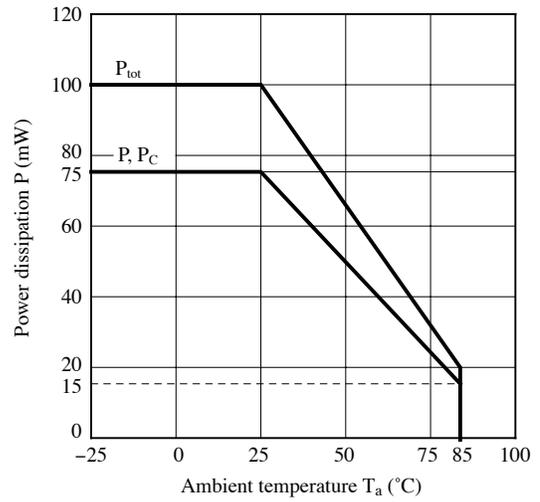
\* The ratio of each rank can not be guaranteed.

Please contact a local SHARP sales representative to see the actual status of the production.

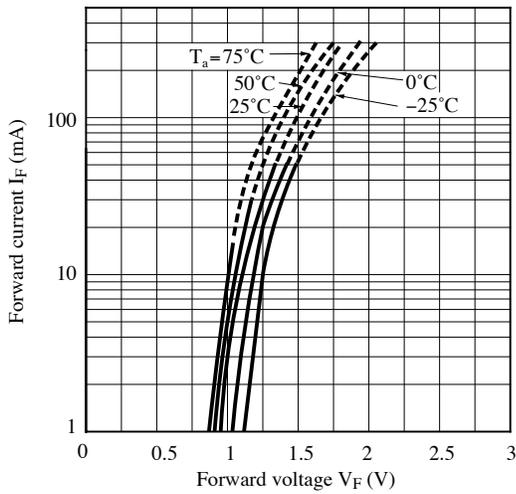
**Fig.1 Forward Current vs. Ambient Temperature**



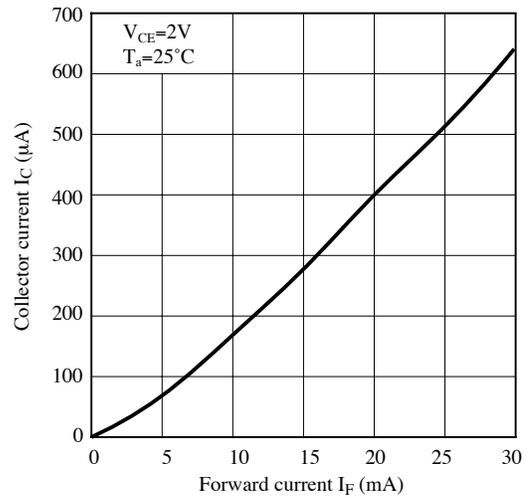
**Fig.2 Power Dissipation vs. Ambient Temperature**



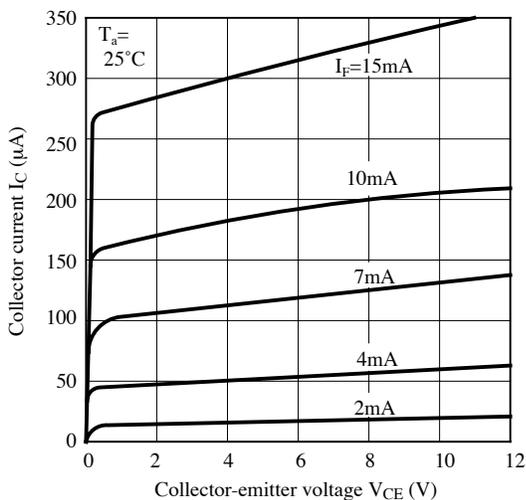
**Fig.3 Forward Current vs. Forward Voltage**



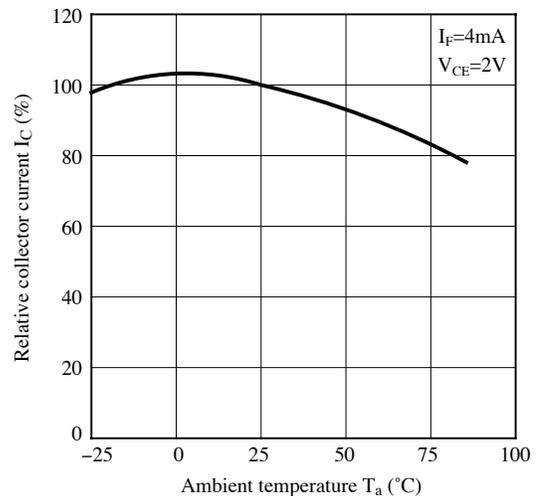
**Fig.4 Collector Current vs. Forward Current**



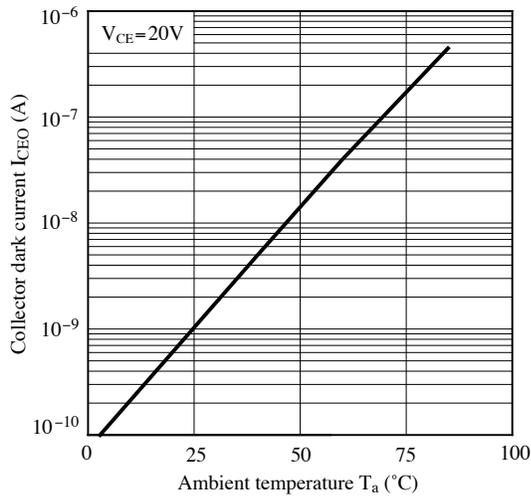
**Fig.5 Collector Current vs. Collector-Emitter Voltage**



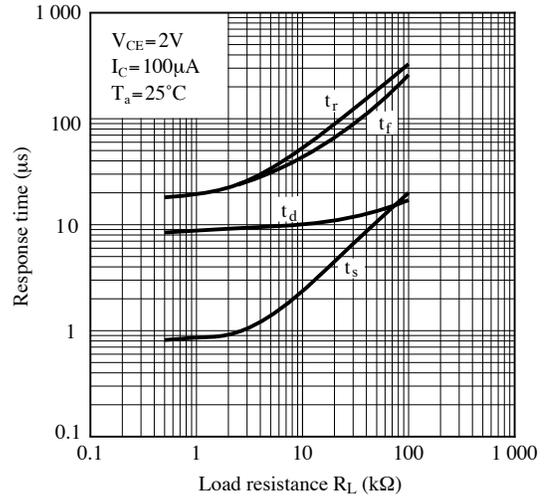
**Fig.6 Relative Collector Current vs. Ambient Temperature**



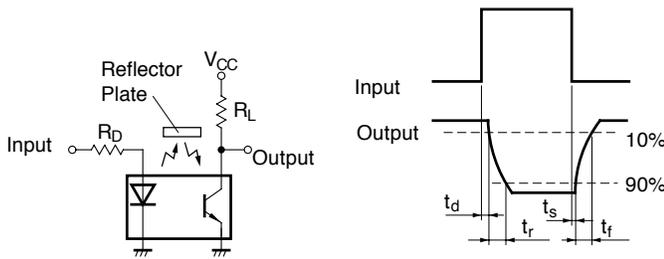
**Fig.7 Collector Dark Current vs. Ambient Temperature**



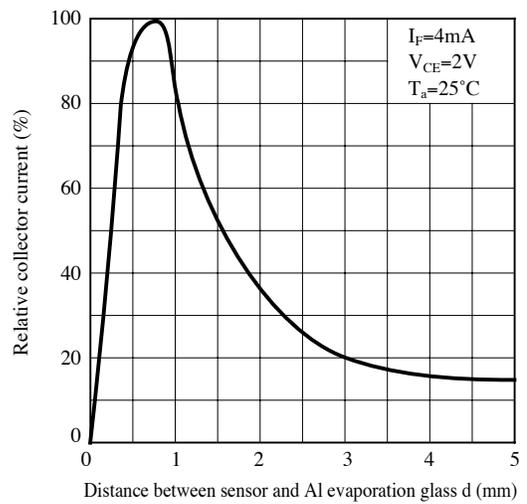
**Fig.8 Response Time vs. Load Resistance**



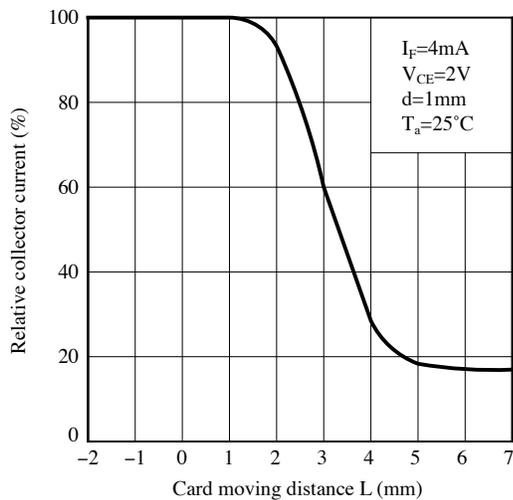
**Fig.9 Test Circuit for Response Time**



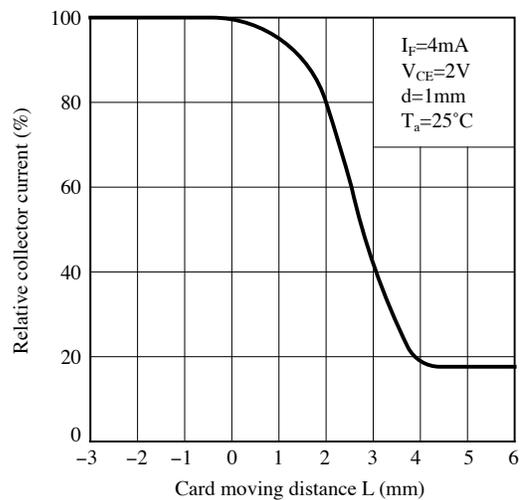
**Fig.10 Relative Collector Current vs. Distance (Reference value)**



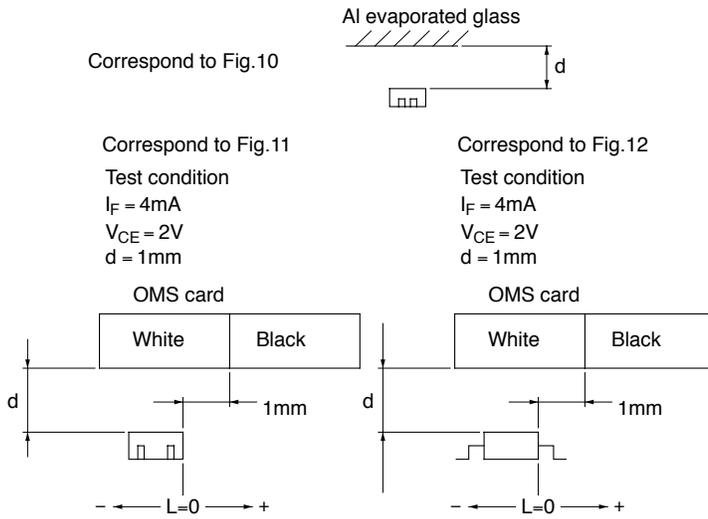
**Fig.11 Detecting Position Characteristics (1)**



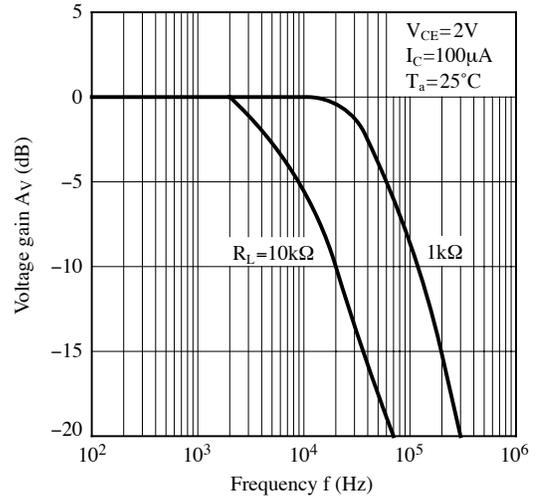
**Fig.12 Detecting Position Characteristics (2)**



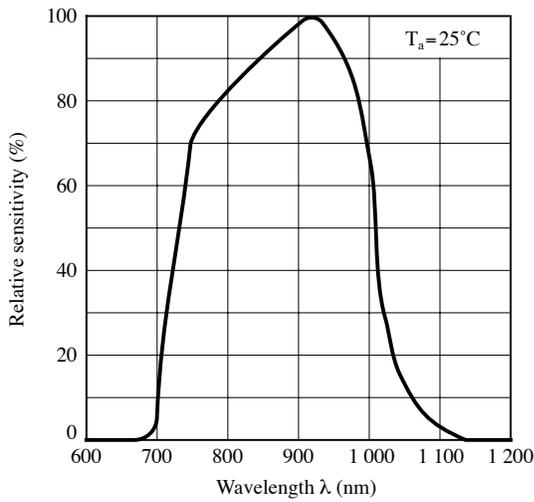
**Fig.13 Test Condition for Distance & Detecting Position Characteristics**



**Fig.14 Frequency Response**



**Fig.15 Spectral Sensitivity (Detecting Side)**



Remarks : Please be aware that all data in the graph are just for reference and not for guarantee.

## ■ Design Considerations

### ● Design guide

1) Prevention of detection error

To prevent photointerrupter from faulty operation caused by external light, do not set the detecting face to the external light.

2) Distance characteristic

Please refer to Fig.10 (Relative collector current vs. Distance) to set the distance of the photointerrupter and the object.

This product is not designed against irradiation and incorporates non-coherent IRED.

### ● Degradation

In general, the emission of the IRED used in photointerrupter will degrade over time.

In the case of long term operation, please take the general IRED degradation (50% degradation over 5 years) into the design consideration.

### ● Parts

This product is assembled using the below parts.

#### • Photodetector (qty. : 1)

Category	Material	Maximum Sensitivity wavelength (nm)	Sensitivity wavelength (nm)	Response time (μs)
Phototransister	Silicon (Si)	930	700 to 1 200	20

#### • Photo emitter (qty. : 1)

Category	Material	Maximum light emitting wavelength (nm)	I/O Frequency (MHz)
Infrared emitting diode (non-coherent)	Gallium arsenide (GaAs)	950	0.3

#### • Material

Case	Lead frame	Lead frame plating
Black polyphenylene sulfide resin	42Alloy	SnCu plating

## ■ Manufacturing Guidelines

### ● Storage and management after open

#### Storage condition

Storage temp.: 5 to 30°C, Storage humidity : 70%RH or less at regular packaging.

#### Treatment after opening the moisture-proof package

After opening, you should mount the products while keeping them on the condition of 5 to 25°C and 70%RH or less in humidity within 4 days.

After opening the bag once even if the prolonged storage is necessary, you should mount the products within two weeks.

And when you store the rest of products you should put into a DRY BOX. Otherwise after the rest of products and silicagel are sealed up again, you should keep them under the condition of 5 to 30°C and 70%RH or less in humidity.

#### Baking before mounting

When the above-mentioned storage method could not be executed, please process the baking treatment before mounting the products.

However the baking treatment is permitted within one time.

Recommended condition : 125°C, 16 to 24 hours

\*Do not process the baking treatment with the product wrapped. When the baking treatment processing, you should move the products to a metallic tray or fix temporarily the products to substrate.

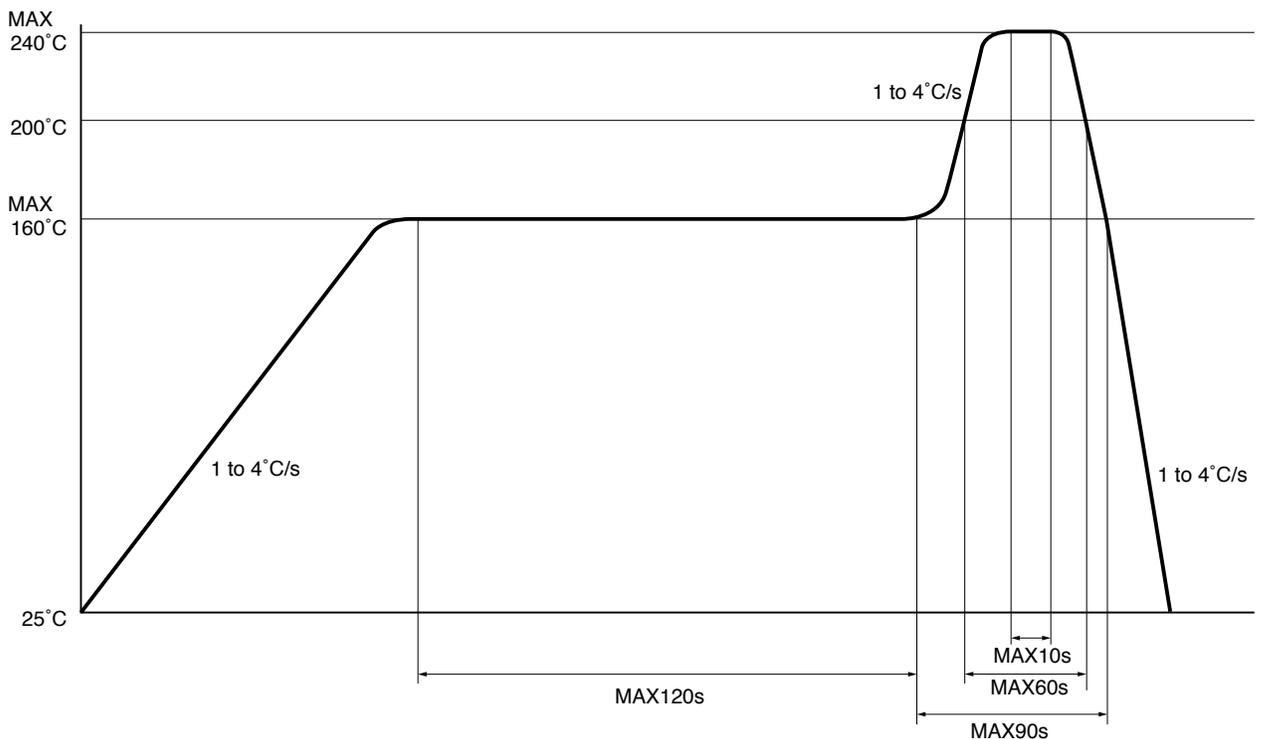
### ● Soldering Method

#### Reflow Soldering:

Reflow soldering should follow the temperature profile shown below.

Soldering should not exceed the curve of temperature profile and time.

Please solder within one time.



### Other notice

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the cooling and soldering conditions.

### Lead pin

Lead terminals of this product are tin copper alloy plated. Before usage, please evaluate solderability with actual conditions and confirm. And the uniformity in color for the lead terminals are not specified.

## ● Cleaning instructions

### Solvent cleaning :

Solvent temperature should be 45°C or below. Immersion time should be 3 minutes or less.

### Ultrasonic cleaning :

Do not execute ultrasonic cleaning.

### Recommended solvent materials :

Ethyl alcohol, Methyl alcohol and Isopropyl alcohol.

## ● Presence of ODC

This product shall not contain the following materials.

And they are not used in the production process for this product.

Regulation substances : CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBBOs and PBBs are not used in this product at all.

This product shall not contain the following materials banned in the RoHS Directive (2002/95/EC).

•Lead, Mercury, Cadmium, Hexavalent chromium, Polybrominated biphenyls (PBB), Polybrominated diphenyl ethers (PBDE).

**■ Package specification****● Sleeve package**

## Package materials

Sleeve : Polystyrene

Stopper : Styrene-Butadiene

Aluminum laminated bag : Nylon, Polyethylene, Aluminum

## Package method

MAX. 50 pcs. of products shall be packaged in a sleeve. Both ends shall be closed by tabbed and tabless stoppers.

MAX. 40 sleeves in one case.

## Color of sleeve

Rank classification is distinguished by the color of the sleeve as shown in the table below.

But the ratio of each rank can not be guaranteed.

Rank	Color of sleeve
A	Yellow
B	Transparent
C	Green

**● Tape and Reel package**

## Package materials

Carrier tape : A-PET (with anti-static material)

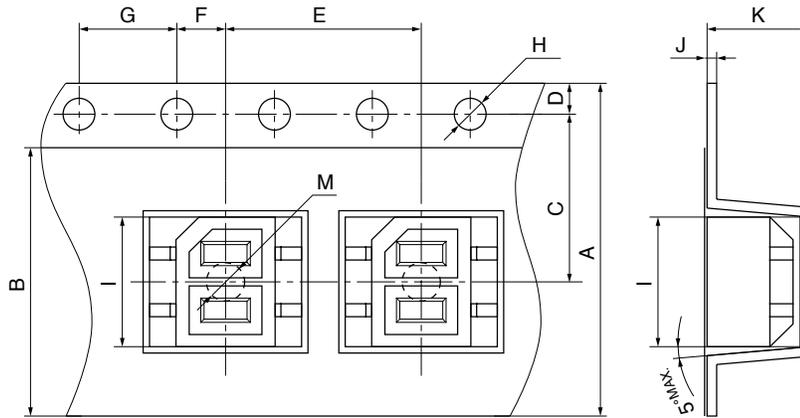
Cover tape : PET (three layer system)

Reel : PS

## Package method

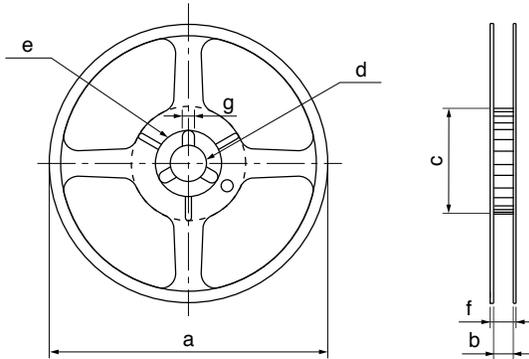
1 000 pcs of products shall be packaged in a reel. One reel with silicagel is encased in aluminum laminated bag. After sealing up the bag, it encased in one case (5 bags/case).

### Carrier tape structure and Dimensions



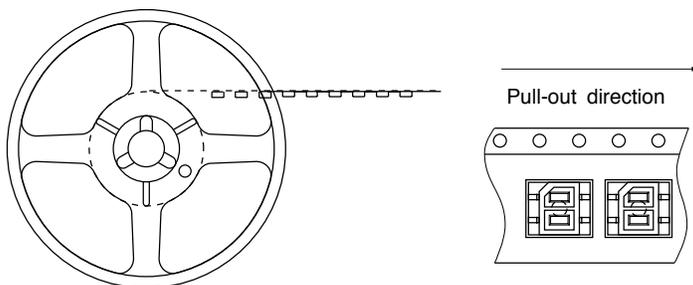
Dimensions List							(Unit : mm)
A	B	C	D	E	F	G	
12 $\pm$ 0.3	7.6 $^{+0.3}_{-0}$	5.5 $\pm$ 0.05	1.75 $\pm$ 0.1	8 $\pm$ 0.1	2 $\pm$ 0.05	4 $\pm$ 0.1	
H	I	J	K	L	M		
$\phi$ 1.5 $^{+0.1}_{-0}$	4.4 $\pm$ 0.1	0.3 $\pm$ 0.05	2 $\pm$ 0.1	5.2 $\pm$ 0.1	$\phi$ 1.6 $^{+0.1}_{-0}$		

### Reel structure and Dimensions



Dimensions List				(Unit : mm)
a	b	c	d	
180	13 $\pm$ 0.8	60 $^{+0.5}_{-0}$	13 $\pm$ 0.2	
e	f	g		
21 $\pm$ 0.8	15.4 $\pm$ 1	2 $^{+0.3}_{-0}$		

### Direction of product insertion



[Packing : 1 000pcs/reel]

### Storage method

Storage conditions should follow the condition shown below.

Storage temperature : 5 to 30°C

Storage humidity : 70%RH or less

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- Office automation equipment
- Telecommunication equipment [terminal]
- Test and measurement equipment
- Industrial control
- Audio visual equipment
- Consumer electronics

(ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection

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- Transportation control and safety equipment (i.e., aircraft, trains, automobiles, etc.)
- Traffic signals
- Gas leakage sensor breakers
- Alarm equipment
- Various safety devices, etc.

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- Telecommunication equipment [trunk lines]
- Nuclear power control equipment
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